

<b>Notice of References Cited</b>	Application/Control No. 10/526,941		Applicant(s)/Patent Under Reexamination YODH ET AL.	
	Examiner BRITTANY M. MARTINEZ		Art Unit 1793	Page 1 of 1

#### U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-7,288,238 B2	10-2007	Smalley et al.	423/447.1
*	B	US-2003/0170166 A1	09-2003	Smalley et al.	423/447.1
*	C	US-7,125,502 B2	10-2006	Smalley et al.	252/378R
*	D	US-5,648,523	07-1997	Chiang, Long Y.	562/100
*	E	US-2002/0176982 A1	11-2002	Rohrbaugh et al.	428/323
*	F	US-6,872,444 B2	03-2005	McDonald et al.	428/206
*	G	US-2002/0028288 A1	03-2002	Rohrbaugh et al.	427/180
*	H	US-2002/0045010 A1	04-2002	Rohrbaugh et al.	427/372.2
*	I	US-2002/0172773 A1	11-2002	Ghosh et al.	427/372.2
	J	US-			
	K	US-			
	L	US-			
	M	US-			

#### FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

#### NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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	X	

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